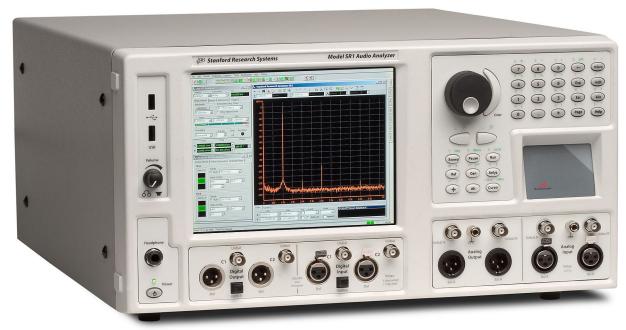
Audio Analyzer

SR1 — Dual-domain audio analyzer





- Analog/digital domain measurements
- -112 dB THD + N (at 1 kHz, 20 kHz BW)
- 200 kHz frequency range
- -118 dBu analyzer noise (20 kHz BW)
- ±0.008 dB flatness (20 Hz to 20 kHz)
- -140 dB input crosstalk
- -125 dB output crosstalk
- <600 ps jitter (50 Hz to 100 kHz)
- Dual-channel FFT measurements
- SR1 ... \$8400 (U.S. list)

SR1 Audio Analyzer

Introducing SR1 Dual-Domain Audio Analyzer — high performance audio analysis at a very affordable price.

SR1 is a stand-alone instrument that delivers cutting edge performance in a wide variety of audio measurements. With a versatile high-performance generator, an array of analyzers that operate symmetrically in both the analog and digital domains, and digital audio carrier measurements at sampling rates up to 192 kHz, SR1 is the right choice for the most demanding analog and digital audio applications.

User Interface

SR1 uses an integrated computer running the Windows XP embedded operating system, so operation will be immediately familiar and intuitive. Depending on the application, SR1 can be operated with an external mouse and keyboard, or by using the front-panel knob, keypad and touchpad.

Seven on-screen tabbed pages are available for arranging panels, graphs, and displays. Screen setups, data, and instrument configurations can be quickly saved and recalled to either the internal hard disk or to a flash drive connected to one of the two front-panel USB connectors. An optional 1024×768 XVGA monitor (opt. 02) provides better resolution and allows more information to be displayed.

While SR1's configuration panels offer total flexibility in setting up every detail of the analyzer, at times it is useful to get a measurement going quickly, without worrying



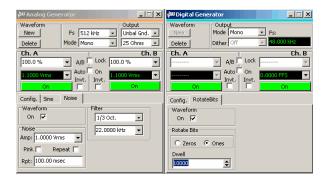
about infrequently used parameters. That's where QuickMeas comes in. QuickMeas gives SR1 users the ability to get up and running on many common audio measurements such as Level, SNR, Frequency Response, and Crosstalk after answering just a few simple questions about the inputs and outputs of the DUT. When the measurements are finished, the results are available in a clear, easy-to-understand report.

Analog Signal Generator

At the heart of SR1 is a uniquely flexible analog signal generator. All of the standard audio waveforms are available including sine, log-swept sine chirp, synchronous burst sine, noise (white, pink, and filtered), standard intermodulation test signals (SMPTE, CCIF, DIM), square waves, arbitrary waveforms (ASCII and .WAV), ramps, MLS and multitone waveforms. Many of these signals can be combined in the generator allowing you to create an unlimited number of test waveforms.

But the analog signal generator doesn't sacrifice performance for flexibility. With a flatness of ± 0.008 dB (20 Hz to 20 kHz) and a residual THD + N of -106 dB (20 Hz to 20 kHz), SR1's Low Distortion Sine rivals the performance of any analyzer.

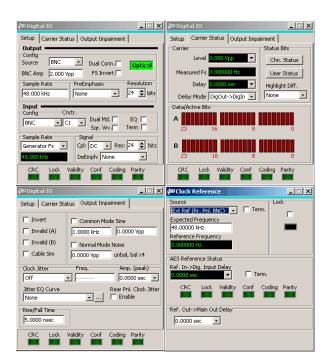
Multitone waveforms with up to 50 tones, each adjustable in frequency, amplitude, and phase are calculated and loaded in real-time, without having to run a cumbersome off-line program to generate arbitrary waveform tables. A convenient FFT Chirp waveform is automatically synchronized to the FFT analyzer allowing instant FFT measurements of frequency response (magnitude and phase).



Analog and digital signal generator panels

Digital Audio Signal Generator

The same flexibility and performance is found in SR1's digital audio signal generator. Almost all the same waveforms found in the analog generator are available in the digital generator with the addition of several special digital test waveforms including digital constant, walking bits, and a staircase waveform (for D/A testing).



Digital I/O panels

The digital audio output sampling rate is continuously adjustable from 24 kHz to 216 kHz (single and dual connector). Full control over transmitted status bits (in both professional and consumer formats), user bits, and validity bits, is provided.

For digital interface testing, a variety of impairment signals can be imposed on the digital audio carrier. Carrier impairments include variable rise time (5 ns to 400 ns), common mode sine waves, normal mode noise, and several jitter waveforms (sine, square, and noise).

Timebase

All of SR1's sampling clocks are derived from an internal timebase with 5 ppm accuracy. For the most demanding applications, an optional atomic rubidium (PERF10) timebase is available with an accuracy at shipment of $\pm 5 \times 10^{-11}$, and a 20-year aging specification of less than 5 ppb. Additionally, the timebase may be synchronized to an external clock, an AES11 reference signal, or any standard video signal.

Analyzers

The heart of SR1's measurement abilities is its versatile set of analyzers which operate symmetrically on both analog and digital audio signals with no need to purchase additional options. Up to two analyzers can be run simultaneously on either the analog or digital inputs.



The *Time Domain Detector* makes all of the standard audio measurements including Amplitude, Crosstalk, and THD + N. Continuously variable bandwidth limiting and standard weighting filters are included. The post notch-filter distortion signal can be fed to an FFT analyzer for a live spectral display of distortion, or to the rear-panel monitor output or speaker.

The Single-Channel FFT and Dual-Channel FFT analyzers offer live spectral displays with full zoom and heterodyne capability. The full resolution of the analyzer can be applied to any frequency range down to 1/512th of the full measurement bandwidth, leading to an effective resolution of 16M FFT lines. Several averaging algorithms can be applied to bring out low level signals.

The two-channel FFT analyzer offers true single-shot frequency response measurements for the ultimate in accuracy. SR1 also has a complete set of impulse response measurements including impulse response, quasi-anechoic frequency response, and energy time-curve. Since SR1 is a true two-channel FFT, it isn't limited to MLS waveforms, but can use virtually any waveform.

The *THD Analyzer* makes frequency selective THD measurements on two user-selectable sets of up to thirteen harmonics of the input signal.

The *IMD Analyzer* makes standard audio distortion measurements including SMPTE, CCIF, and DIM. Frequency selective analysis ensures high measurement accuracy.

The *Histogram Analyzer* displays live histograms of input signal amplitudes and probability distributions. Realtime fits to Gaussian distributions can be generated.

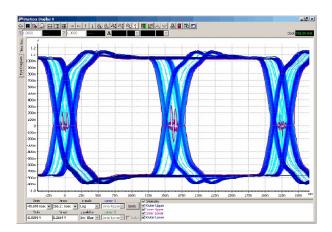
The *Multitone Analyzer*, in combination with the *Multitone Generator*, can be configured to make fast single-shot measurements of a variety of audio parameters including Level, Frequency Response, THD + N, THD, Total Distortion, Noise, Crosstalk, and IMD.

Digital Audio Interface Measurements

SR1 provides a complete set of measurements for digital interface testing. Carrier level and sampling frequency are measured directly. Status bits are fully decoded in both professional and consumer formats, and user bits are displayed as well. SR1's *Jitter Analyzer* measures jitter in both the time and frequency domain, including continuously variable bandwidth limiting and weighting in both domains. For frequency domain measurements, live zoomable and heterodyned spectral displays of jitter are available. Using the jitter chirp waveform, you can characterize jitter transfer functions in under a second. With a residual jitter of only 600 ps, the performance of SR1's jitter analyzer is unbeatable.

Digitizer

An optional 80 MHz transient digitizer (Opt. 01) provides additional digital audio carrier analysis. Operating on a record



Eye diagram

of up to 2M samples, the digitizer computes and displays the time record of the input signal and its jitter, input spectrum, jitter spectrum, and the probability distributions of the input and jitter amplitudes as well as the pulse width and pulse rate. Full color eye-diagrams can be generated allowing easy testing against user-configurable eye limits.

Automation and Programming

SR1 offers unprecedented flexibility for user scripting and remote programming. On-board scripts can be written in VBScript, Jscript, or Python with full access to all of the instrument's capabilities as well as the ability to create simple user-interfaces for running tests. SR1 has a complete hierarchical GPIB command set, and GPIB commands can be sent over the standard IEE-488 interface, RS-232 port, or over the Ethernet on a TCP/IP network (VXI-11). Finally, SR1 has a complete COM interface allowing instrument operation to be automated from any COM capable application such as Visual Basic, LabView, or Microsoft Office.

Learning Mode

Learning mode is a powerful tool for quickly creating scripts without detailed knowledge of the programming environment. SR1 creates a script by recording each keystroke or user operation, and then converts the script to a VB script or Jscript program. These programs can be saved and edited like any other script, then run in the future.



SR1 rear panel



Analog Signal Generator

General Characteristics

Amplitude range (rms) 1 µV to 28.3 V (balanced)

1 μV to 14.1 V (unbalanced)

Amplitude accuracy $\pm 0.5\%$ (± 0.043 dB) at 1 kHz

Frequency range

Hi BW DAC 10 Hz to 200 kHz

10 Hz to 0.45 Fs (Fs: 128 kHz or Hi Res DAC

64 kHz fixed, 24 kHz to 216 kHz adj.)

Frequency accuracy $\pm 0.0005\% (5 ppm)$

 $< F_S/2^{24}$ Frequency resolution

Output configuration Balanced Ground, Balanced Float,

Unbalanced Ground, Unbalanced

Float, Common Mode Test

Source impedance 50Ω , 150Ω , 600Ω (balanced)

 25Ω , 75Ω , 600Ω (unbalanced)

Max. power (600 Ω load)

30.5 dBm Balanced Unbalanced 24.9 dBm Float voltage $\pm 40 \, V$

Crosstalk

10 Hz to 20 kHz $-125 \, dB$ $>20\,\mathrm{kHz}$ $-100 \, dB$

Waveforms

Low Distortion Sine

Flatness (relative to 1 kHz)

 $\pm 0.020\,dB~(typ.~\pm 0.012\,dB)$ 20 Hz to 20 kHz

10 Hz to 64 kHz $\pm 0.025 \, dB$ $10 \, \text{Hz} \text{ to } 200 \, \text{kHz} = \pm 0.05 \, \text{dB}$

Residual THD+N

1 kHz, 4 Vrms -112 dB (22 kHz BW) 20 Hz to 20 kHz $-106 \, dB + 1 \, \mu V \, (22 \, kHz \, BW)$

 $-100.5 \, dB + 1.7 \, \mu V \, (80 \, kHz \, BW)$

 $-97 \, dB + 2.5 \, \mu V \, (200 \, kHz \, BW)$

10 Hz to 100 kHz $-89 \text{ dB} + 2.5 \,\mu\text{V} (200 \,\text{kHz BW})$

Regular Sine

Flatness (relative to 1 kHz, amplitude ≤4 Vrms)

20 Hz to 20 kHz ± 0.008 dB (typ. ± 0.003 dB)

 $10 \,\mathrm{kHz}$ to $64 \,\mathrm{kHz}$ $\pm 0.02 \,\mathrm{dB}$ $10 \, \text{Hz} \text{ to } 200 \, \text{kHz} \pm 0.03 \, \text{dB}$ Residual THD+N (Hi BW DAC)

> -86 dB (22 kHz BW) 1 kHz 22 Hz to 20 kHz $-85 \, dB + 1 \, \mu V \, (22 \, kHz \, BW)$

 $-84.5 \, dB + 1.7 \, \mu V \, (80 \, kHz \, BW)$ $-82 \, dB + 2.5 \, \mu V \, (200 \, kHz \, BW)$

 $10 \text{ Hz to } 100 \text{ kHz} -77 \text{ dB} + 2.5 \,\mu\text{V} (200 \,\text{kHz BW})$

Residual THD+N (Hi Res DAC, $F_s = 128 \text{ kHz}$) 1 kHz -99 dB (22 kHz BW)

22 Hz to 20 kHz $-98 \text{ dB} + 1 \mu\text{V} (22 \text{ kHz BW})$ $20 \text{ Hz to } 57.6 \text{ kHz} -96.5 \text{ dB} + 1.4 \mu\text{V} (57.6 \text{ kHz BW})$

Residual THD+N (Hi Res DAC, $F_s = 64 \text{ kHz}$) 1 kHz -106 dB (22 kHz BW) 20 Hz to 20 kHz $-101 \, dB + 1 \, \mu V \, (22 \, kHz \, BW)$ Phased Sines 0 to 360° , 0.001° resolution *IMD* SMPTE/DIN, CCIF/DFD, DIM/TIM Noise White, Pink, Filtered White/Pink,

USASI

Multitone 1 to 50 tones

Repetition rates from 28 to 220 MLSFFT Chirp Equal power in each FFT bin

Log-sine chirp Swept-sine w/ log increasing frequencies 10 Hz to 50 kHz frequency range Square Ramp Fs/N frequency range (N≥20) Arbitrary 256 Samples to 136k Samples **Polarity** 10 Hz to Fs/4 frequency range Constant (Offset) DC to $20 V_p$ (unbal)/ $40 V_p$ (bal)

Bursts

Burst types Timed, ext. triggered, ext. gated,

synchronous sine, shaped.

Digital Audio Signal Generator

Digital Audio Carrier Characteristics

Output amplitude

Balanced

Range $16\,\mathrm{mV}$ to $10.2\,\mathrm{V}$ ($110\,\Omega$ load)

Accuracy $\pm 10\% + 80 \, mV$

Unbalanced

 $4 \,\mathrm{mV}$ to $2.55 \,\mathrm{V}$ (75 Ω load) Range

Accuracy $\pm 10\% + 20 \, \text{mV}$

Output format Balanced XLR (AES/EBU),

> dual-connector XLR, unbalanced BNC (SPDIF-EIAJ), dual-connector

BNC, Optical (Toslink)

Output sample rate 24 kHz to 216 kHz

Sample rate accuracy ± 5 ppm

Output impedance 110Ω (balanced)

75 Ω (unbalanced)

Digital Audio Waveforms

Sine

Frequency range 10 Hz to Fs/2 $< Fs/2^{24}$ Frequency resolution Flatness $\pm 0.001 \, dB$ Harmonic/spurious $-148 \, dB$

Phased Sine 0 to 360° range, 0.01° resolution Square 10 Hz to Fs/2 frequency range SMPTE/DIN, CCIF/DFD, DIM/TIM IMDWhite, Pink, Filtered White/Pink, Noise

Repetition rates from 2^8 to 2^{20} MLS Fs/N frequency range (N≥20) Ramp 256 Samples to 136k Samples *Arbitrary* FFT Chirp Equal power in each FFT bin.

Log-swept sine chirp Swept-sine with log increasing frequencies

Polarity 10 Hz to Fs/4 frequency range



phone: (408)744-9040 www.thinkSRS.com

Bursts

Burst waveforms All allowed waveforms

Burst types Timed

Digital Test Waveforms Digital Constant, Count, Rotating

Bits, Staircase, J-Test

Dither None, triangle and rectangular

probability distribution

Digital Audio Carrier Impairments

Jitter

Waveforms Sine, square, uniform noise,

BP filtered noise, chirp

Frequency range 2 Hz to 200 kHz Amplitude range 0 UI to 13 UI

Amplitude range Normal Mode Noise

Amplitude range

 $\begin{array}{ccc} \text{Unbalanced} & 0 \text{ to } 637 \, \text{mV}_{pp} \\ \text{Balanced} & 0 \text{ to } 2.55 \, \text{V}_{pp} \end{array}$

Common Mode Sine

Amplitude range $0 \text{ to } 20 \text{ V}_{pp} \text{ (balanced only)}$

Frequency range 10 Hz to 100 kHz

Cable Simulation Simulates 100 m of digital cable

Variable Rise Time 5 ns to 400 ns

Signal Measurements

General Analog Input Characteristics

Input range (Vrms) 62.5 mV to 160 V

Input configuration XLR, BNC, Generator Monitor,

Digital Audio Common Mode

Input impedance

Balanced $200 \, k\Omega/95 \, pF$ Unbalanced $100 \, k\Omega/185 \, pF$ Input termination (bal) $300 \, \Omega$, $600 \, \Omega$, $200 \, k\Omega$

Crosstalk

 $10 \text{ Hz to } 50 \text{ kHz} \leq -140 \text{ dB}$ >50 kHz $\leq -135 \text{ dB}$

Hi BW ADC

Type 16-bit sigma-delta

Sampling freq. 512 kHz Frequency range DC to 228 kHz

Hi Res ADC

Type 24-bit sigma-delta Sampling freq. 128 kHz or 64 kHz (fixed),

24 kHz to 216 kHz (adj.)

Frequency range DC to 0.45Fs

General Digital Input Characteristics

Input format Balanced XLR (AES/EBU),

dual-connector XLR, unbalanced BNC (SPDIF-EIAJ), dual-connector

BNC, Optical (Toslink)

Input sample rate 24 kHz to 216 kHz

Input impedance Hi Z or 110Ω (balanced)

Hi Z or 75Ω (unbalanced)

Analog Signal Meters

RMS Level Meter

Accuracy (1 kHz ref) ±0.5 % (±0.043 dB) Flatness (1 kHz ref, amplitude less than 4 Vrms) 20 Hz to 20 kHz <±0.008 dB (typ. <±0.003 dB)

 $\begin{array}{ll} 10\,\text{Hz to } 64\,\text{kHz} & <\!\!\pm\!0.02\,\text{dB} \\ 10\,\text{Hz to } 200\,\text{kHz} & <\!\!\pm\!0.03\,\text{dB} \end{array}$

Frequency Meter

Range 8 Hz to 300 kHz

Accuracy timebase error \pm (2 ppm + 10 mHz)

Phase Meter

Accuracy $\pm 1.0^{\circ}$

Digital Signal Meters

Frequency Meter 10 Hz to 0.45Fs, ±100 ppm accuracy

Phase Meter $\pm 0.05^{\circ}$ accuracy (f ≥ 50 Hz)

Analyzers (Analog and Digital Audio)

Time Domain Analyzer

Measurements Amplitude, amplitude ratio,

THD+N, THD+N ratio, SINAD, Crest Factor

Analog Inputs:

Amplitude accuracy $\pm 0.5\%$ (± 0.043 dB)

Flatness (1 kHz ref)

50 Hz to 20 kHz $< \pm 0.008 \text{ dB (typ. } \pm 0.003 \text{ dB)}$

 $20 \,\text{Hz} \text{ to } 64 \,\text{kHz} \qquad <\pm 0.02 \,\text{dB} \\ 10 \,\text{Hz} \text{ to } 200 \,\text{kHz} \qquad <\pm 0.05 \,\text{dB}$

Residual noise (62.5 Vrms input range, shorted input)

Hi Res ADC (Fs=128 kHz) 22 Hz to 22 kHz <-117.5 dBu 22 Hz to 57.6 kHz <-115 dBu A-Weighted <-120 dBu

Hi BW ADC

22 Hz to 22 kHz <-118 dBu 22 Hz to 80 kHz <-113 dBu 22 Hz to 200 kHz <-110 dBu A-Weighted <-120 dBu

Residual THD+N

Hi Res ADC (Fs = $128 \,\text{kHz}$)

1 kHz, 4 Vrms -111 dB (22 kHz BW)

 $20 \, \text{Hz} \text{ to } 20 \, \text{kHz} -107 \, \text{dB} + 0.8 \, \mu\text{V} \, (22 \, \text{kHz BW})$

 $-101 \, dB + 1.3 \, \mu V \, (57.6 \, kHz \, BW)$

Hi Res ADC (Fs=64kHz)

1 kHz, 4 Vrms -111 dB (22 kHz BW)

 $20 \,\text{Hz}$ to $20 \,\text{kHz}$ $-107 \,\text{dB} + 0.8 \,\mu\text{V}$ (22 kHz BW)

Hi BW ADC

1 kHz, 4 Vrms -113 dB (22 kHz BW)

 $20 \, \text{Hz} \text{ to } 20 \, \text{kHz} -109 \, \text{dB} + 0.8 \, \mu \text{V} \, (22 \, \text{kHz BW})$

 $-102 \, dB + 1.5 \, \mu V \, (80 \, kHz \, BW)$

 $-98 \, dB + 2.5 \, \mu V \, (200 \, kHz \, BW)$

10 Hz to 100 kHz -91 dB (200 kHz BW)



SR1 Specifications

Digital Inputs:

Amplitude accuracy $\pm 0.001 \, dB \, (at \, 1 \, kHz)$

Flatness $\pm 0.001 \, dB \, (15 \, Hz \text{ to } 22 \, kHz)$

Residual THD+N -140 dBFS

Bandwidth limiting filters

Low pass filter 4th order Butterworth, adj. from

Fs/40 to $0.45Fs,\,20\,kHz,\,40\,kHz$ and $80\,kHz$ fixed elliptical filters

per AES17.

High pass filter 4th order Butterworth, @ 22 Hz,

 $100\,Hz,$ and $400\,Hz.$ $20\,kHz,$ $40\,kHz$ and $80\,kHz$ fixed elliptical

filters per AES17.

Band pass filter

Response

Hi BW ADC 1/3 Octave, Class II (4-pole) Hi Res ADC 1/3, 1/6, 1/12, 1/24 Octave,

Class III (6-pole)

Tuning range

Hi BW ADC 10 Hz to 200 kHz Hi Res ADC 10 Hz to 0.44Fs

Tuning accur. $\pm 2.5 \%$ Amplitude accur. $\pm 0.5 \%$

Notch filters Tuning range

> Hi BW ADC 10 Hz to 200 kHz Hi Res ADC 10 Hz to 0.44Fs

Tuning accuracy ±2.5%

Response $-3 \, dB$ at 0.73 Fc and 1.37 Fc Ampl. accuracy $\pm 0.2 \, dB$ (20 Hz to 180 kHz,

 $f < 0.5f_0 \text{ or } f > 2f_0$

Weighting filters A-wt, C-Msg wt, CCITT, CCIR

(weighted, unweighted, 2 kHz norm)

Detector response RMS, Peak, Quasi-Peak (CCIR-468)

Single-Channel and Dual-Channel FFT Analyzers

Frequency range

THD Analyzer

Hi BW ADC
Hi Res ADC
DC to 200 kHz
DC to 0.45Fs

Number of FFT lines
Processing
DC to 200 kHz
DC to 40-bit floating point

Windows Blackman Harris, Enhanced
Blackman Harris, Hann, Hamming,
Equiripple, Flattop, Gaussian,

Kaiser, Uniform, Rife Vincent 4,

5 and 10 term

Zoom Span can be narrowed by up to 512× Heterodyne Narrowed span can be centered

anywhere in the measurement range

Averaging fixed length and continuous
Dual-channel meas. Frequency, Impulse and Quasi-

anechoic Response, Coherence, Energy Time Curve, Group Delay Measures two independent sets of

user-selectable harmonics (2× to 14×)

IMD Analyzer SMPTE/DIN, CCIF/DFD,

DIM/TIM

Histogram Analyzer Time vs. amplitude, Histogram,

PDF, Gaussian fit to PDF

Multitone Analyzer Level, Frequency Response, THD

THD+N, noise, IMD, Crosstalk

Digital Audio Carrier Measurements

Measurements Carrier amplitude, sample rate,

jitter amplitude, jitter spectrum

Sample rate 24 kHz to 216 kHz

 $\begin{array}{ll} \text{Sample rate accuracy} & \pm 5 \text{ ppm} \\ \text{Carrier amplitude measurements} \\ \text{Balanced (XLR)} & \pm 10 \,\% + 80 \,\text{mV} \\ \text{Unbalanced (BNC)} \pm 10 \,\% + 20 \,\text{mV} \end{array}$

Optical Displays voltage of Toslink receiver
Output to input delay Measures delay from Digital Audio

Output or AES11 reference output

to Digital Audio Input

Range -12.7 UI to +115.1 UI in seconds

Resolution 60 ns

Residual jitter

 $50 \,\mathrm{Hz}$ to $100 \,\mathrm{kHz}$ $\leq 600 \,\mathrm{ps}$

Reference

Input sources AES11 (24 Hz to 216 kHz),

sine or TTL (8 kHz to 32 MHz), video (NTSC/PAL/SECAM)

Reference Output AES11 (24 to 216 kHz)

Optional Digitizer (Opt. 01)

Sampling rate 80 MHz

Acquisition length 4k, 8k, 16k, 128k, 256k, 512k, 1M,

2M samples

Measurements Input vs. time, jitter vs. time, input

spectrum, jitter spectrum, pulse width/rate histograms, jitter probability histogram, eye diagrams

General

Computer interfaces GPIB, RS-232, Ethernet, COM.
Video out VGA output for external monitor
Power <250 W, 90 to 264 VAC, 47 to 63 Hz,

Dimensions $17" \times 8.5" \times 20.25"$ (WHD)

Weight 40 lbs.

Warranty One year parts and labor on defects

in materials and workmanship

Ordering Information

SR1 Audio analyzer \$8400
Option 01 80 MHz digitizer \$1500
Option 02 High resolution display \$600
O1RM Rack mount kit for SR1 \$100



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